

# **Regulatating Pulse Width Modulator**

## Description

**Block Diagram** 

The SG1524B is a pulse width modulator for switching power supplies that features improved performance over industry standards like the SG1524. A direct pin-for-pin replacement for the earlier device, it combines advanced processing techniques and circuit design to provide improved reference accuracy, and extended common mode range at the error amplifier and current limit inputs. A DC-coupled flip-flop eliminates triggering and glitch problems, and a PWM data latch prevents edge oscillations.

The circuit incorporates true digital shutdown for high speed response, while an undervoltage lockout circuit prevents spurious outputs when the supply voltage is too low for stable operation. Full double-pulse suppression logic insures alternating output pulses when the Shutdown pin is used for pulse-by-pulse current limiting.

The SG1524B is specified for operation over the full military ambient temperature range of  $-55^{\circ}$ C to  $125^{\circ}$ C. The SG2524B is characterized for the industrial range of  $-25^{\circ}$ C to  $85^{\circ}$ C, and the SG3524B is designed for the commercial range of 0°C to 70°C.

### Features

- 7V to 40V Operation
- 5V Reference Trimmed to ±1%
- 100Hz to 400kHz Oscillator Range
- Excellent External Sync Capability
- Dual 100 mA Output Transistors
- Wide Current Limit Common Mode Range
- DC-Coupled Toggle Flip-flop
- PWM Data Latch
- Undervoltage Lockout
- Full Double-pulse Suppression Logic
- 60V Output Collectors

### High Reliability Features -SG1524B

- Available to MIL-STD-883, ¶1.2.1
- MSC-AMS level "S" Processing Available
- Available to DSCC
  - Standard Microcircuit Drawing (SMD)

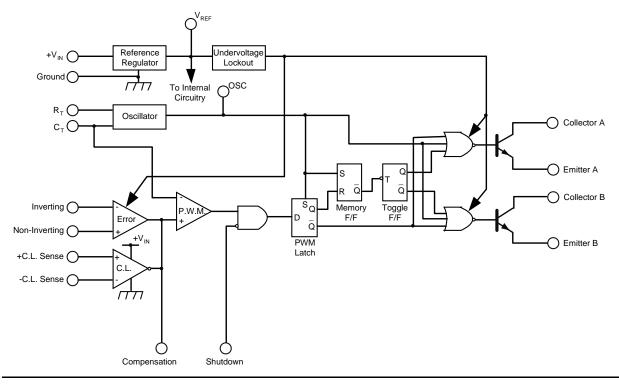


Figure 5 - Block Diagram



## **Connection Diagrams and Ordering Information**

Ambient Temperature	Туре	Package	Part Number	Packaging Type	Connection Diagram
			SG1524BJ		INV. Input $\begin{array}{c c} 1 \\ 1 \\ \end{array}$ 16 $\begin{array}{c c} V_{REF} \\ \hline N.I. Input \\ 2 \\ \end{array}$ 15 $\begin{array}{c c} +V_{IN} \\ \hline \end{array}$ OSC. Output $\begin{array}{c c} 3 \\ \end{array}$ 14 $\begin{array}{c c} E_B \\ \hline \end{array}$
55°C to 125°C	J	16-PIN Ceramic Dual Inline Package	SG1524BJ-883B	CERDIP	+C.L. Sense 4 13 C <sub>B</sub> -C.L. Sense 5 12 C <sub>A</sub>
			SG1524BJ-DESC		$ \begin{array}{cccccccccccccccccccccccccccccccccccc$
-25°C to 85°C	N	16-PIN Dual	SG2524BN		N Package: RoHS Compliant / Pb-
0°C to 70°C	N	Inline Plastic Package	SG3524BN	PDIP	free Transition DC: 0503 N Package: RoHS / Pb-free 100% Matte Tin Lead Finish
-25°C to 85°C	DW	16-PIN Small Outline Wide	SG2524BDW	SOWB	$\begin{array}{c c c c c c c c c c c c c c c c c c c $
0°C to 70°C		Body Package	SG3524BDW	3000	DW Package: RoHS Compliant / Pb- free Transition DC: 0516 DW Package: RoHS / Pb-free 100% Matte Tin Lead Finish
-55°C to	L	20-Pin Ceramic	SG1524BL-883B	CLCC	1. N.C. 3 2 1 20 19 11. N.C. 2. INV. Input 4 4. OSC. Output 5 5. +C.L. Sense 6 6. N.C. 16 I.S. C.
-55 ℃ 10 125°C		Leadless Chip Carrier	SG1524BL		7. C.L. Sense 7 8. R <sub>7</sub> 8 9. C <sub>7</sub> 10. Ground 9 10 11 12 13 15 17. C <sub>8</sub> 14 18. E <sub>8</sub> 19. +V <sub>8</sub> 20. V <sub>REF</sub>

Note:

1. Contact factory for DESC product availability.

All packages are viewed from the top.
 Hermetic Packages J, & L use Sn63/Pb37 hot solder lead finish, contact factory for availability of RoHS versions

4. Available in Tape & Reel. Append the letters "TR" to the part number. (i.e. SG3524BDW-TR)



## **Absolute Maximum Ratings**

Parameter	Value	Units
Input Voltage, (+V <sub>IN</sub> )	42	V
Collector Voltage	60	V
Logic Inputs	-0.3 to 5.5	V
Current Limit Sense Inputs	-0.3 to V <sub>IN</sub>	V
Output Current (Each transistor)	200	mA
Reference Load Current	50	mA
Oscillator Charging Current	5	mA
Operating Junction Temperature		
Hermetic (J, L Packages)	150	C°
Plastic (N, DW Packages)	150	C°
Storage Temperature Range	-65 to 150	°C
Lead Temperature (Soldering, 10 seconds)	300	°C
RoHS Peak Package Solder Reflow Temp. (40 sec. max. exp.)	260 (+0, -5)	C°
Note: 1. Values beyond which damage may occur		

## **Thermal Data**

Parameter	Value	Units
J Package		
Thermal Resistance-Junction to Case, $\theta_{JC}$	30	°C/W
Thermal Resistance-Junction to Ambient, $\theta_{JA}$	80	°C/W
N Package		
Thermal Resistance-Junction to Case, $\theta_{JC}$	40	°C/W
Thermal Resistance-Junction to Ambient, $\theta_{JA}$	65	°C/W
DW Package		
Thermal Resistance-Junction to Case, $\theta_{JC}$	40	°C/W
Thermal Resistance-Junction to Ambient, $\theta_{JA}$	95	°C/W
L Package		
Thermal Resistance-Junction to Case, $\theta_{JC}$	35	°C/W
Thermal Resistance-Junction to Ambient, $\theta_{JA}$	120	°C/W
Note:		•

 Junction Temperature Calculation: T<sub>J</sub> = T<sub>A</sub> + (P<sub>D</sub> x θ<sub>JA</sub>).
 The above numbers for θ<sub>JC</sub> are maximums for the limiting thermal resistance of the package in a standard mounting configuration. The  $\theta_{JA}$  numbers are meant to be guidelines for the thermal performance of the device/pc-board system. All of the above assume no ambient airflow.



## Recommended Operating Conditions<sup>1</sup>

Parameter	Value	Units
Input Voltage (+V <sub>IN</sub> )	7 to 40	V
Collector Voltage	0 to 60	V
Error Amp Common Mode Range	2.3 to V <sub>REF</sub>	V
Current Limit Sense Common Mode Range	0 to V <sub>IN</sub> - 2.5V	V
Output Current (Each transistor)	0 to 100	mA
Reference Load Current	0 to 20	mA
Oscillator Charging Current	25 to 1.8	µA/mA
Oscillator Frequency Range	100 to 400	Hz/kHz
Oscillator Timing Resistor (R <sub>T</sub> )	2 to 150	kΩ
Oscillator Timing Capacitor (CT)	1 to 0.1	nF/µF
Operating Ambient Temperature Range		
SG1524B	-55 to 125	°C
SG2524B	-25 to 85	°C
SG3524B	0 to 70	°C
<i>Note:</i> 1. Range over which the device is functional.	•	

### **Electrical Characteristics**

(Unless otherwise specified, these specifications apply over the operating ambient temperatures for SG1524B with -55°C  $\leq$  T<sub>A</sub>  $\leq$  125°C, SG2524B with -25°C  $\leq$  T<sub>A</sub>  $\leq$  85°C, SG3524B with 0°C  $\leq$  T<sub>A</sub>  $\leq$  70°C, and +V<sub>IN</sub> = 20V. Low duty cycle pulse testing techniques are used that maintains junction and case temperatures equal to the ambient temperature.)

Deremeter	Test Conditions	SG	SG1524B/2524B			SG3524B		
Parameter	Test Conditions	Min.	Тур.	Max	Min.	Тур.	Max	Units
Reference Section <sup>1</sup>								
Output Voltage	TJ = 25°C	4.95	5.00	5.05	4.90	5.00	5.10	V
Line Regulation	$V_{IN} = 7V$ to $40V$		3	20		3	30	mV
Load Regulation	I∟= 0 to 20mA		5	30		5	50	mV
Temperature Stability <sup>5</sup>	Over Operating Temperature Range		15	50		15	50	mV
Total Output Voltage Range	Over Line, Load and Temperature	4.90		5.10	4.80		5.20	V
Short Circuit Current	V <sub>REF</sub> = 0V	25	50	120	25	50	120	mA
Undervoltage Lockout S	Section							
Threshold Voltage		4.3	4.5	4.7	4.2	4.5	4.9	V

2.  $F_{OSC} = 45 \text{ kHz} (R_T = 2700 \Omega, C_T = .01 \mu F)$ 3.  $V_{CM} = 2.3V \text{ to } V_{REF}$ 

4.  $V_{CM} = 0V$  to 17.5V

5. These parameters, although guaranteed over the recommended operating conditions, are not tested in production.

Parameter	Test	SG1524B/2524B			SG3524B			
Parameter	Test Conditions	Min.	Тур.	Max	Min.	Тур.	Max	Units
Oscillator Section <sup>2</sup>								
Initial Accuracy	$T_J = 25^{\circ}C$	42	45	48	40	45	50	kHz
Voltage Stability	$V_{IN} = 7V$ to $40V$		0.1	1		0.1	1	%
Temperature Stability <sup>5</sup>	Over Operating Range		1	2		1	2	%
Minimum Frequency <sup>5</sup>	$R_{T} = 150 k\Omega, C_{T} = 0.1 \mu F$		50	140		50	120	Hz
Maximum Frequency	R <sub>T</sub> = 2 kΩ, C <sub>T</sub> = 470pF	400	600		400	600		kHz
Sawtooth Peak Voltage	$V_{IN} = 40V$		3.5	3.9		3.5	3.9	V
Sawtooth Valley Voltage	$V_{IN} = 7V$	0.6	1		0.6	1		V
Clock Amplitude		3.0	4.0		3.0	4.0		V
Clock Pulse Width		0.2	0.5	1.2	0.2	0.5	1.2	μs
Error Amplifier Section	3						I	
Input Offset Voltage	Rs≤2kΩ		0.5	5		2	10	mV
Input Bias Current			1	5		1	10	μA
Input Offset Current				1			1	μA
DC Open Loop Gain	R∟ ≥ 10MΩ	60	78		60	78		dB
Output Low Level	I <sub>SINK</sub> = 100µA; V <sub>PIN 1</sub> - V <sub>PIN 2</sub> ≥ 150mV		0.2	0.5		0.2	0.5	V
Output High Level	I <sub>SOURCE</sub> = 100µA; V <sub>PIN 2</sub> - V <sub>PIN 1</sub> ≥ 150mV	3.8	4.2		3.8	4.2		V
Common Mode Rejection	$V_{CM} = 2.3V$ to $V_{REF}$	70	90		70	90		dB
Supply Voltage Rejection	$V_{IN} = 7V$ to $40V$	76	100		76	100		dB
Gain-Bandwidth Product⁵	T <sub>J</sub> = 25°C	1	2		1	2		MHz
P.W.M. Comparator <sup>2</sup>	·							
Minimum Duty Cycle	$V_{COMP} = 0.5V$			0			0	%
Maximum Duty Cycle	V <sub>COMP</sub> = 3.9V	45	49		45	49		%
Current Limit Amplifier	Section <sup>4</sup>	•					· · · · · ·	
Sense Voltage		180	200	220	170	200	230	mV
	1	1	1		1			

## Electrical Characteristics (continued)

1.  $I_L = 0mA$ 2.  $F_{OSC} = 45kHz (R_T = 2700 \ \Omega, C_T = .01 \mu F)$ 3.  $V_{CM} = 2.3V \text{ to } V_{REF}$ 4.  $V_{CM} = 0V \text{ to } 17.5V$ 5. These parameters, although guaranteed over the recommended operating conditions, are not tested in production.

Parameter	Test One little	SG1	SG1524B/2524B			SG3524B		
	Test Conditions	Min.	Тур.	Max	Min.	Тур.	Max	Units
Shutdown Input Sectio	n							
HIGH Input Voltage		2.0			2.0			V
HIGH Input Current	V <sub>SHUTDOWN</sub> = 5V		0.1	1		0.1	1	mA
LOW Input Voltage				0.6			0.6	V
Output Section (Each tr	ansistor)	•		•	•	•		
Collector Leakage Current	V <sub>CE</sub> = 60V			50			50	μA
Collector Saturation Voltage	I <sub>C</sub> = 10mA		0.2	0.4		0.2	0.4	V
	$I_C = 100 \text{mA}$		1.0	2.0		1.0	2.0	V
	$I_E = 10 \text{mA}$	17.5	19		17.5	19		V
Emitter Output Voltage	I <sub>E</sub> = 100mA	17	18		17	18		V
Emitter Voltage Rise Time <sup>5</sup>	$R_E = 2k\Omega, T_A = 25^{\circ}C$		0.2	0.5		0.2	0.5	μs
Collector Voltage Fall Time	$R_c = 2k\Omega, T_A = 25^{\circ}C$		0.1	0.2		0.1	0.2	μs
Power Consumption								
<u> </u>	$V_{IN} = 40V,$		5	12		5	12	mA
Standby Current							14	

4.  $V_{CM} = 0V$  to 17.5V 5. These parameters, although guaranteed over the recommended operating conditions, are not tested in production.



## **Characteristic Curves**

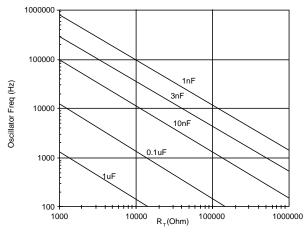


Figure 2 · Oscillator Frequency vs. Timing Resistor and Capacitor  $V_{IN}$  = 20V,  $T_A$  = 25°C

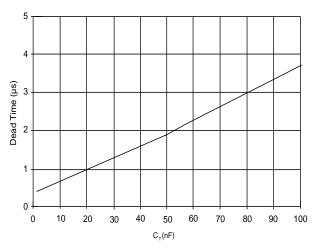


Figure 3 - SG1524B Dead Times vs. Timing Capacitance ( $R_T = 2.7k\Omega$ )  $V_{IN} = 20V$ ,  $T_A = 25^{\circ}C$ 

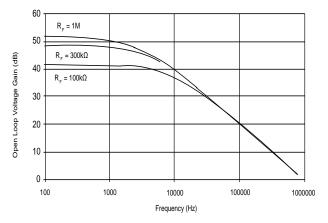
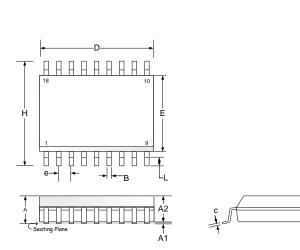


Figure 4 · SG1524B Error Amp Voltage Gain vs. Freq Over  $R_F$ ;  $V_{IN}$  = 20V,  $T_A$  = 25°C

## Package Outline Dimensions

Controlling dimensions are in inches, metric equivalents are shown for general information.



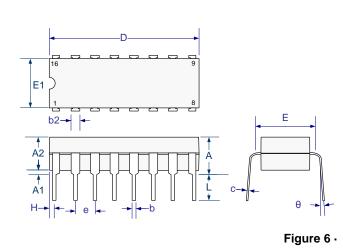
Dim	MILLIMETERS INC		HES	
Diin	MIN	MAX	MIN	MAX
А	1.35	1.75	0.053	0.069
A1	0.10	0.25	0.004	0.010
A2	1.25	1.52	0.049	0.060
b	0.33	0.51	0.013	0.020
с	0.19	0.25	0.007	0.010
D	9.78	10.01	0.385	0.394
Е	5.79	6.20	0.228	0.244
е	1.27	BSC	0.050	) BSC
Н	3.81	4.01	0.150	0.158
L	0.40	1.27	0.016	0.050
Θ	0	8	0	8
*LC		0.10		0.004

\*Lead coplanarity

#### Note:

Dimensions do not include protrusions; these shall not exceed 0.155mm (.006") on any side. Lead dimension shall not include solder coverage.

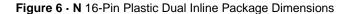
Figure 5 - DW 16-Pin SOWB Package Dimensions

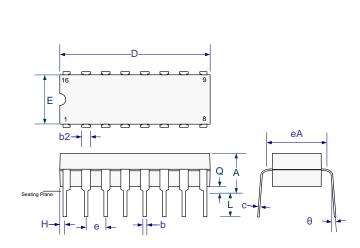


Dim	MILLIMETERS		INC	HES	
Dim	MIN	MAX	MIN	MAX	
Α	-	5.08	-	0.200	
A1	0.38	0.51	0.015	0.040	
A2	3.30	Тур.	0.130 Typ.		
b	0.38	0.51	0.015	0.020	
b2	0.76	1.52	0.030	0.060	
С	0.20	0.38	0.008	0.015	
D	18.54	20.57	0.730	0.810	
÷	2.54 BSC		0.10	D BSC	
E1	6.10	6.60	0.240	0.260	
E	7.62	BSC	0.300	) BSC	
L	3.05		0.120		
θ	-	15°	-	15°	

#### Note:

Dimensions do not include protrusions; these shall not exceed 0.155mm (.006") on any side. Lead dimension shall not include solder coverage.





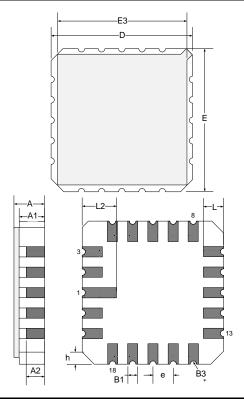
Package Outline Di	mensions
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Dim	MILLIM	ETERS	INC	HES	
Dim	MIN	MAX	MIN	MAX	
Α		5.08		0.200	
b	0.38	0.51	0.015	0.020	
b2	1.04	1.65	0.045	0.065	
С	0.20	0.38	0.008	0.015	
D	19.30	19.94	0.760	0.785	
Е	5.59	7.11	0.220	0.280	
е	2.54 BSC		0.100	D BSC	
eA	7.37	7.87	0.290	0.310	
Н	0.63	1.78	0.025	0.070	
L	3.18	5.08	0.125	0.200	
α	-	15°	-	15°	
Q	0.51	1.02	0.020	0.040	

Note:

Dimensions do not include protrusions; these shall not exceed 0.155mm (.006") on any side. Lead dimension shall not include solder coverage.

Figure 7 - J 16-Pin Ceramic Dual Inline Package Dimensions



Dim	MILLIM	ETERS	INC	HES
Dim	MIN	MAX	MIN	MAX
D/E	8.64	9.14	0.340	0.360
E3	-	8.128	-	0.320
е	1.270	BSC	0.050	D BSC
B1	0.635	TYP	0.02	5 TYP
L	1.02	1.52	0.040	0.060
А	1.626	2.286	0.064	0.090
h	1.016	TYP	0.04	0 TYP
A1	1.372	1.68	0.054	0.066
A2	-	1.168	-	0.046
L2	1.91	2.41	0.075	0.95
B3	0.20	3R	0.0	08R

#### Note:

All exposed metalized area shall be gold plated 60 micro-inch minimum thickness over nickel plated unless otherwise specified in purchase order.

Figure 8 - L 20-Pin Ceramic Leadless Chip Carrier (LCC) Package Outline Dimensions



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